· ·	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	F
10/791,050	LO ET AL	
Examiner	Art Unit	
John Kim	3733	

SEARCHED			
Class	Subclass	Date	Examiner
623	17.16	1/9/2006	JK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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inventor's name search	1/9/2006	JK
East Search Notes	1/9/2006	JK
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